



Image 2829

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
(Case No. 219.002-US)

In the Application of: **Yamada et al.**

Serial No: **09/702,831**

Filed: **November 1, 2000**

Title: **Semiconductor Device Tester**

) Group
) Art Unit: **2829**
)
) Before
) Examiner: **V. Nguyen**
)
)

Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

FEE TRANSMITTAL

Dear Sir:

Transmitted herewith is an **Information Disclosure Statement** (1 page + Form PTO-1449 (2 sheets) and references cited therein.

The fee has been calculated as shown below:

CLAIMS AS AMENDED						
	Claims Remaining	Highest Number Previously Paid	Extra	Rate		Amount
				Large	Small	
Number of Claims In (in excess of 20)	0	0	0	\$18.00	\$9.00	-0-
Independent Claims (in excess of 3)	0	0	0	\$84.00	\$42.00	-0-
Extension Fee: a) One Month				\$110.00	\$55.00	-0-
Filing of Information Disclosure Statement (37 C.F.R. §1.17(p)):						\$180.00
TOTAL FEE DUE:						\$180.00

Method of Payment:

☒ [XX] A check payable to the Commissioner of Patents and Trademarks, in the amount of \$180.00 is enclosed as payment of the Total Fee.

☐ [] Please charge my Deposit Acc. 50-0763 in the amount of \$_____ to cover the above fees. A duplicate copy of this sheet is enclosed.

☒ [XX] The Commissioner is hereby authorized to charge any fees that may be required, or credit any overpayment to Deposit Acc. 50-0763. A duplicate copy of this sheet is enclosed.

Date: March 17, 2004

Respectfully submitted,

Neil Steinberg, Reg. No. 34,735
Telephone No. (650) 968-8079



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Certificate of Mailing under 37 CFR 1.8

I hereby certify that the attached: **(1)** Information Disclosure Statement (1 page + Modified PTO-1449 (2 sheets) and References cited therein); **(2)** Fee Transmittal (1 page + 1 copy thereof); **(3)** Check (\$180.00) are being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to:

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

on March 17, 2004.



Signature



Print Name of Person Signing Certificate



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INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Submitted herewith are two (2) sheets of a modified Form PTO-1449. A copy of each document cited on the attached Form PTO-1449 is also submitted.

Notably, most of the documents listed on the attached Form PTO-1449 were identified and/or cited in applications (namely, U.S. App. Serial Nos. 09/451,440 and 09/865,528) that include subject matter which is similar to that in the above-reference application.

It is respectfully requested that the Examiner make his/her consideration of these documents formally of record with the initial Office Action.

Respectfully submitted,

Date: March 17, 2004

Neil A. Steinberg, Reg. No. 34,735
650-968-8079

PTO-1449 (Modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO.	SERIAL NUMBER
	219.002-US	09/702,831
	APPLICANT(S)	
	Yamada et al.	
	FILING DATE	GROUP ART UNIT
	November 1, 2000	2829

U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	4,949,162	8/1990	Tamaki et al.			
	4,988,877	1/1991	Stokowski et al.			
	5,001,536	3/1991	Fukuzawa et al.			
	5,327,012	7/1994	Yano et al.			
	5,412,210	5/1995	Todokoro et al.			
	5,637,186	6/1997	Liu et al.			
	5,780,870	7/1998	Maeda et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	6-273297	9/1994	Japan			
	7-66172	3/1995	Japan			
	57-6310	1/1996	Japan			
	8-313244	11/1996	Japan			
	9-61142	3/1997	Japan			
	10-300450	11/1998	Japan			
	50-63990	5/1975	Japan			
	62-19707	1/1987	Japan			
	8-5528	1/1996	Japan			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.	



PTO-1449 (Modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO.	SERIAL NUMBER
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U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	5,900,645	5/1999	Yamada			
	6,037,588	3/2000	Liu et al.			
	6,127,193	10/2000	Bang et al.			
	6,317,514	11/2001	Reinhorn et al.			
	3,614,608	10/1971	Giedd et al.			
	5,365,034	11/1994	Kawamura et al.			
	5,453,994	9/1995	Kawamoto et al.			
	5,493,236	2/1996	Ishii et al.			
	5,757,198	5/1998	Shida et al.			
	5,815,002	9/1998	Nikawa			
	6,294,919	9/2001	Baumgart			
	5,089,774	2/1992	Nakano			
	5,132,507	7/1992	Nakano			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	10-281746	10/1998	Japan			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
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